



N-Channel 20-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY

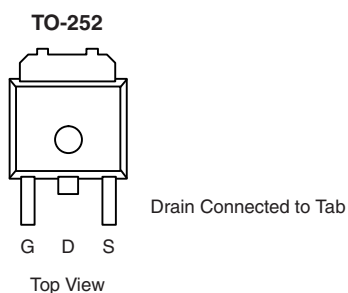
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A) ^a	Q_g (Typ)
20	0.0033 at $V_{GS} = 10$ V	40	30 nC
	0.0044 at $V_{GS} = 4.5$ V	40	

FEATURES

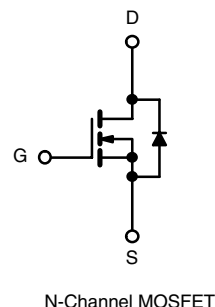
- TrenchFET® Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- Server

RoHS
COMPLIANT

Order Number:
SUD40N02-3m3P-E3 (Lead (Pb)-free)



ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 150$ °C)	$T_C = 25$ °C	I_D	40 ^a	A
	$T_C = 100$ °C		40 ^a	
	$T_A = 25$ °C		24.4 ^b	
	$T_A = 100$ °C		17.2 ^b	
Pulsed Drain Current		I_{DM}	100	
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	40 ^a	
	$T_A = 25$ °C		2.8 ^b	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	79	W
	$T_C = 100$ °C		39.5	
	$T_A = 25$ °C		3.3 ^b	
	$T_A = 100$ °C		1.6 ^b	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	37	45	°C/W
Maximum Junction-to-Case	Steady State	R_{thJC}	1.5	1.9	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

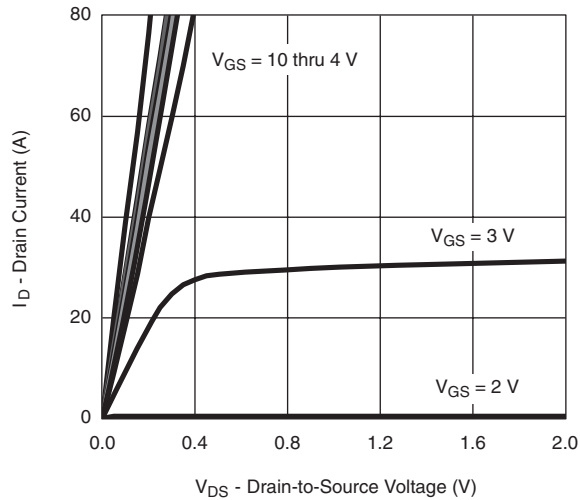
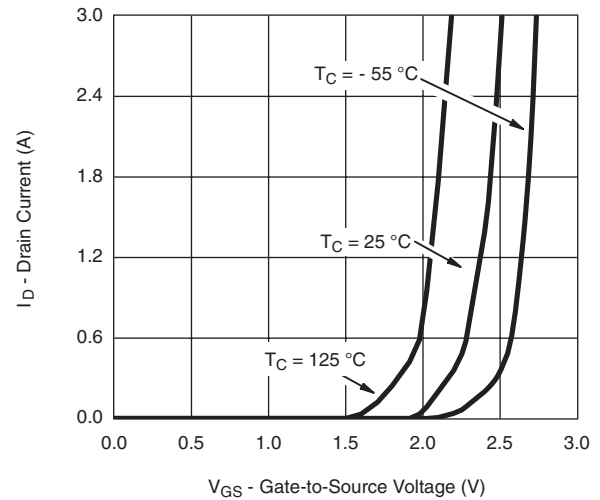
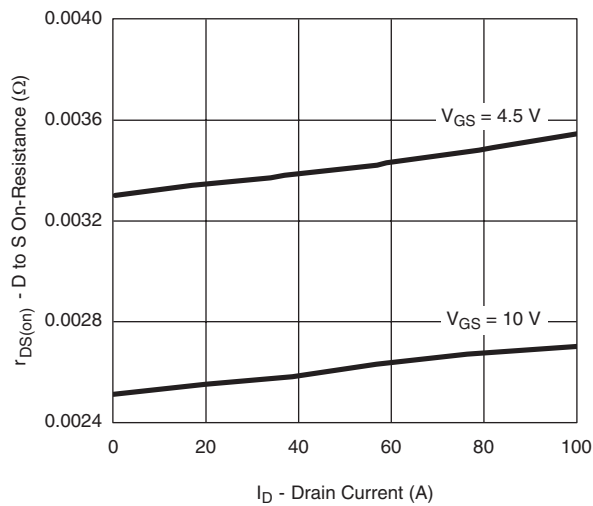
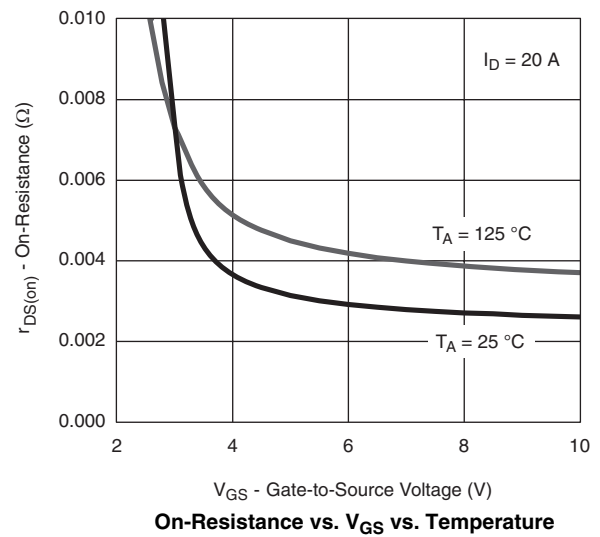
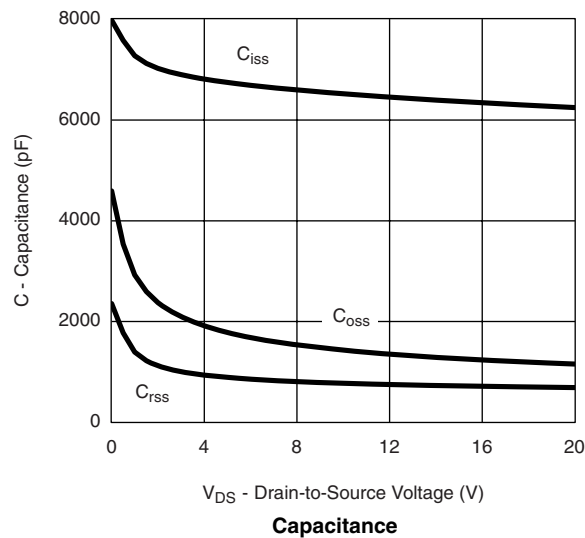
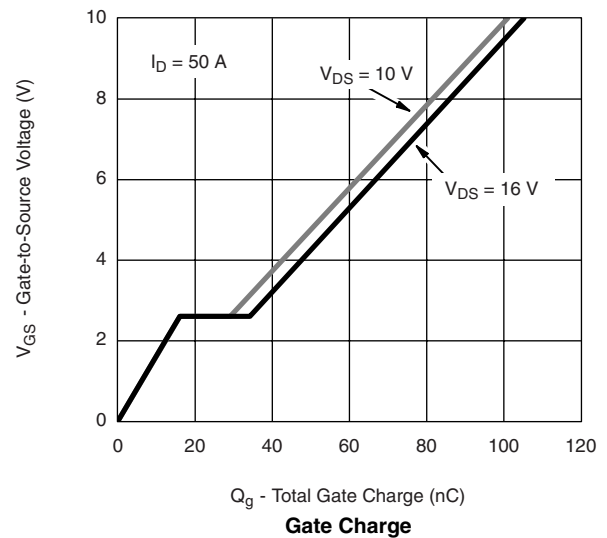
SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		21		mV/ $^{\circ}\text{C}$
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 6.9		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	1		3	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
		$V_{DS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 100\text{ }^{\circ}\text{C}$			20	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}$, $V_{GS} = 10\text{ V}$	30			A
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = 10\text{ V}$, $I_D = 20\text{ A}$		0.0027	0.0033	Ω
		$V_{GS} = 4.5\text{ V}$, $I_D = 20\text{ A}$		0.0036	0.0044	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15\text{ V}$, $I_D = 20\text{ A}$		100		S
Dynamic ^b						
Input Capacitance	C_{iss}	$V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$		6520		pF
Output Capacitance	C_{oss}			1430		
Reverse Transfer Capacitance	C_{rss}			770		
Total Gate Charge	Q_g	$V_{DS} = 10\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 50\text{ A}$		105	160	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = 10\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 50\text{ A}$		50	75	
Gate-Drain Charge	Q_{gd}			17		
Gate Resistance	R_g			14		
Gate Resistance	R_g	$f = 1\text{ MHz}$		1.2	1.9	Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10\text{ V}$, $R_L = 0.2\text{ }\Omega$ $I_D \equiv 50\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\text{ }\Omega$		40	60	ns
Rise Time	t_r			30	45	
Turn-Off Delay Time	$t_{d(off)}$			67	101	
Fall Time	t_f			33	50	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10\text{ V}$, $R_L = 0.2\text{ }\Omega$ $I_D \equiv 50\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\text{ }\Omega$		13	20	
Rise Time	t_r			7	11	
Turn-Off Delay Time	$t_{d(off)}$			40	60	
Fall Time	t_f			9	14	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^{\circ}\text{C}$			40	A
Pulse Diode Forward Current ^a	I_{SM}				100	
Body Diode Voltage	V_{SD}	$I_S = 20\text{ A}$		0.81	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 50\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^{\circ}\text{C}$		38	57	ns
Body Diode Reverse Recovery Charge	Q_{rr}			34	51	nC
Reverse Recovery Fall Time	t_a			18		ns
Reverse Recovery Rise Time	t_b			20		

Notes:

a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

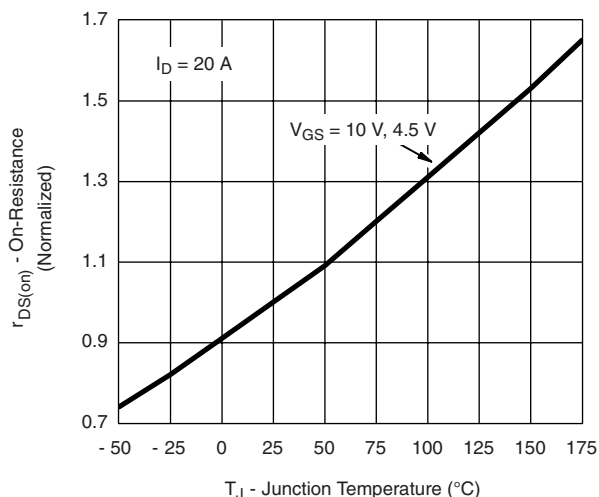
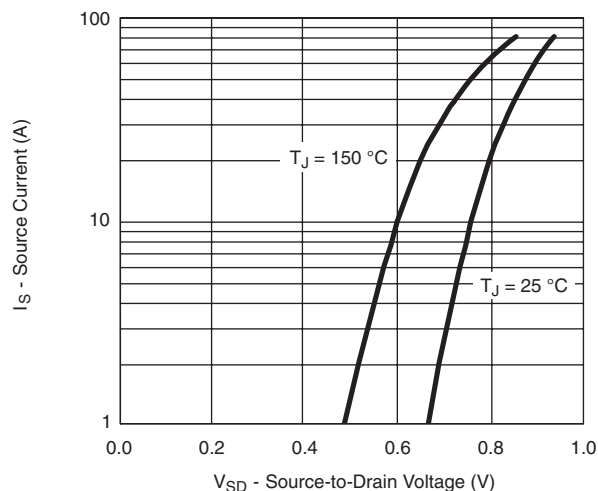
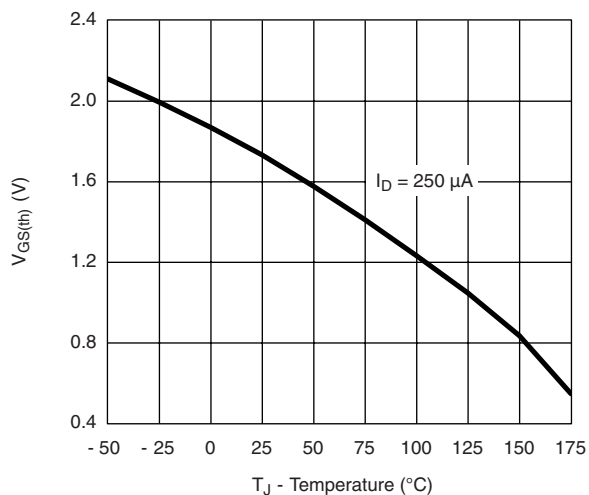
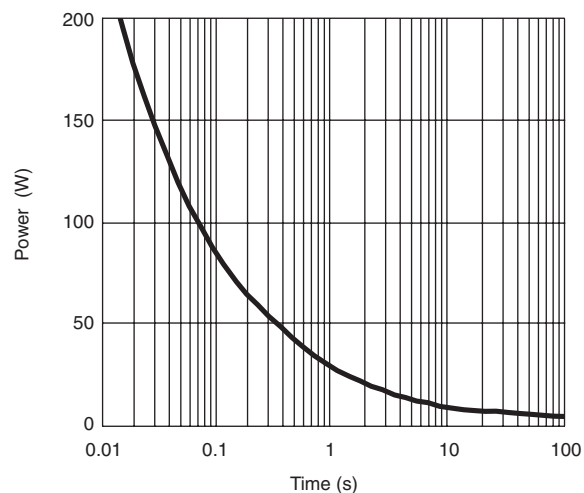
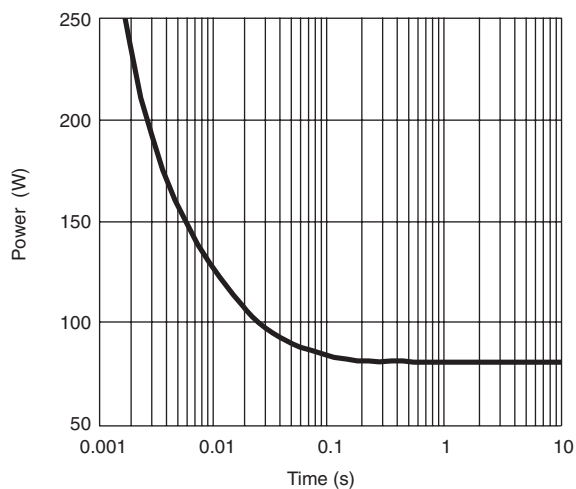
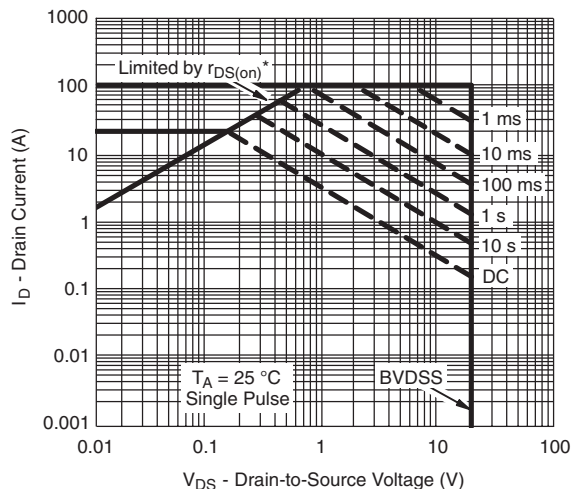
b. Guaranteed by design, not subject to production testing.

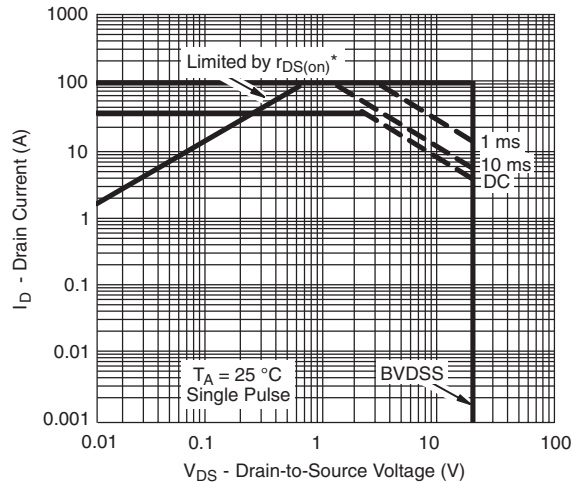
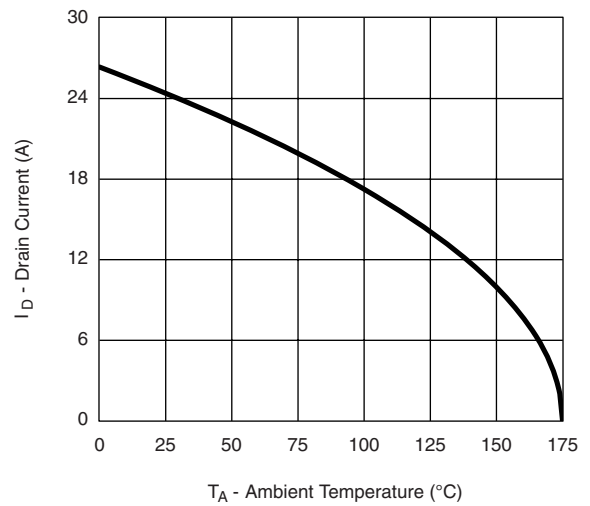
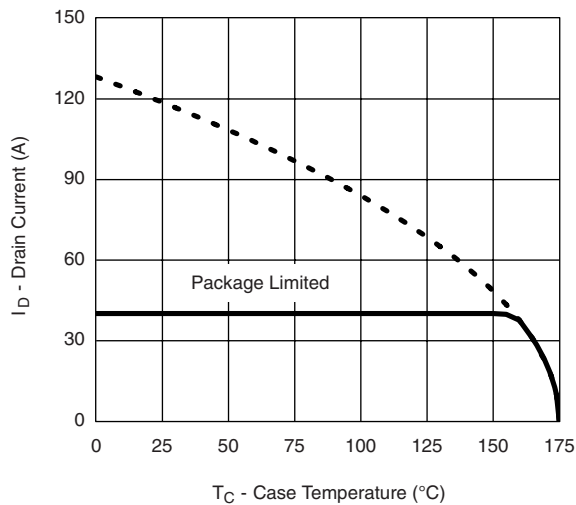
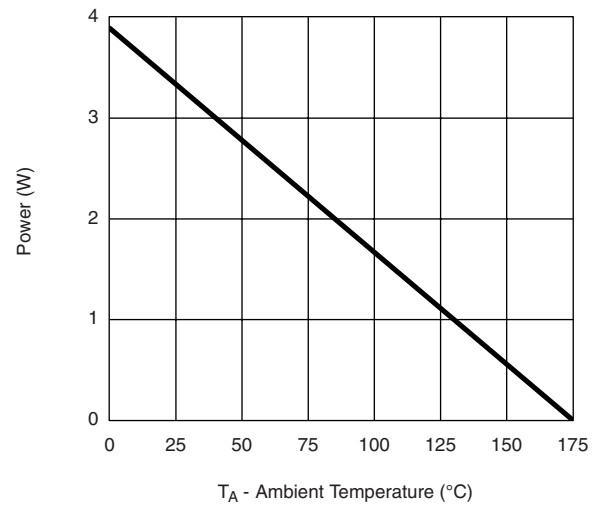
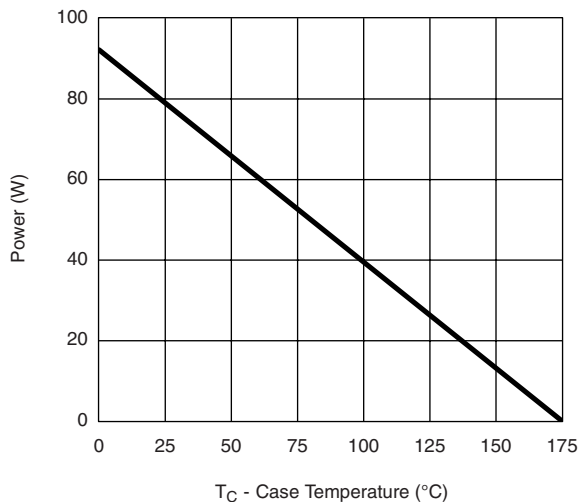
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Output Characteristics****Transfer Characteristics****On-Resistance vs. Drain Current****On-Resistance vs. V_{GS} vs. Temperature****Capacitance****Gate Charge**

SUD40N02-3m3P

Vishay Siliconix

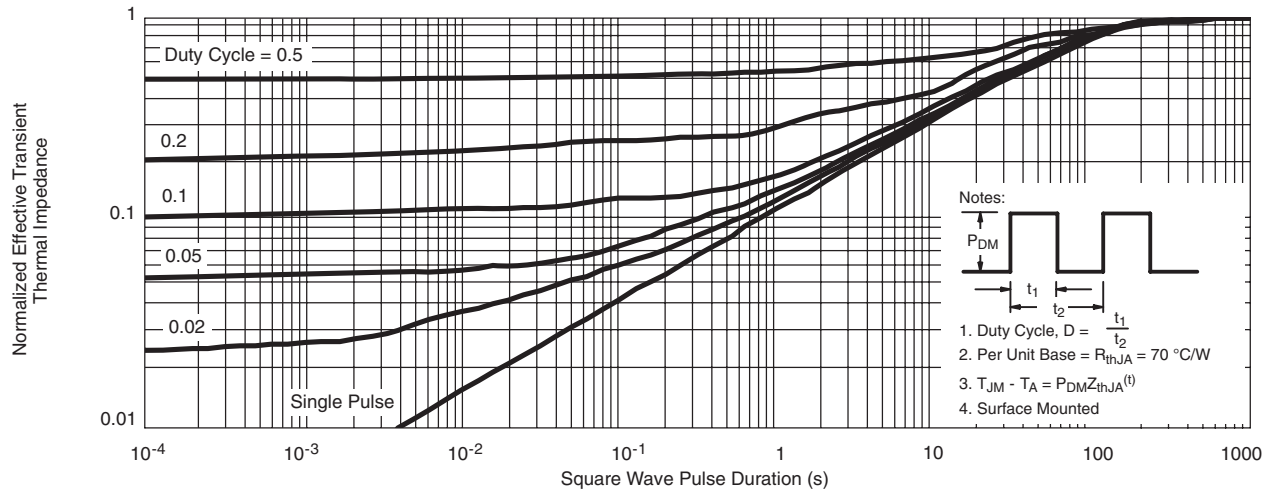
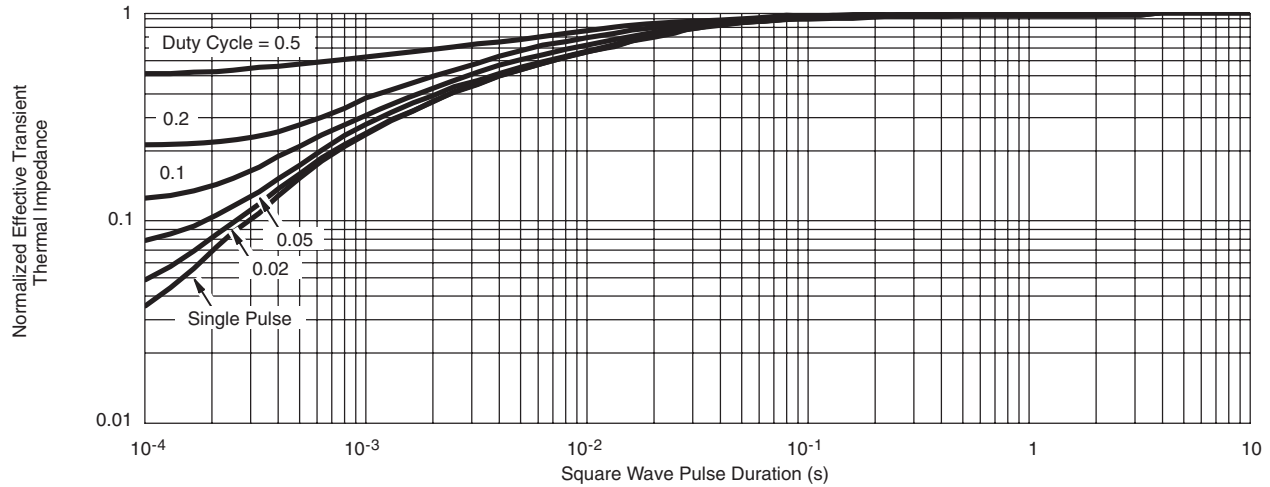
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**On-Resistance vs. Junction Temperature****Forward Diode Voltage vs. Temperature****Threshold Voltage****Single Pulse Power, Junction-to-Ambient****Single Pulse Power, Junction-to-Case*** V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified**Safe Operating Area, Junction-to-Ambient**

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted* $V_{GS} >$ minimum V_{GS} at which $r_{DS(on)}$ is specified**Safe Operating Area, Junction-to-Case****Current Derating**, Junction-to-Ambient****Current Derating**, Junction-to-Case****Power Derating**, Junction-to-Ambient****Power Derating**, Junction-to-Case**

** The power dissipation P_D is based on $T_{J(max)} = 175\text{ }^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

SUD40N02-3m3P

Vishay Siliconix

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Normalized Thermal Transient Impedance, Junction-to-Ambient****Normalized Thermal Transient Impedance, Junction-to-Case**

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